

April 1988 Revised September 2000

# 74F257A

# **Quad 2-Input Multiplexer with 3-STATE Outputs**

#### **General Description**

The 74F257A is a quad 2-input multiplexer with 3-STATE outputs. Four bits of data from two sources can be selected using a Common Data Select input. The four outputs present the selected data in true (non-inverted) form. The outputs may be switched to a high impedance state with a HIGH on the common Output Enable (OE) input, allowing the outputs to interface directly with bus-oriented systems.

#### **Features**

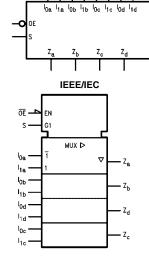
- Multiplexer expansion by tying outputs together
- Non-inverting 3-STATE outputs
- Input clamp diodes limit high-speed termination effects

# **Ordering Code:**

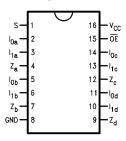
Order Number	Package Number	Package Description
74F257ASC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F257ASJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F257APC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

# **Logic Symbols**



# **Connection Diagram**



© 2000 Fairchild Semiconductor Corporation

DS009507

www.fairchildsemi.com

# **Unit Loading/Fan Out**

Pin Names	December 1	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>		
	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>		
S	Common Data Select Input	1.0/1.0	20 μA/-0.6 mA		
OE	3-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA		
I <sub>0a</sub> –I <sub>0d</sub>	Data Inputs from Source 0	1.0/1.0	20 μA/-0.6 mA		
I <sub>1a</sub> –I <sub>1d</sub>	Data Inputs from Source 1	1.0/1.0	20 μA/-0.6 mA		
Z <sub>a</sub> –Z <sub>d</sub>	3-STATE Multiplexer Outputs	150/40 (33.3)	-3 mA/24 mA (20 mA)		

#### **Truth Table**

Output Enable	-		ata uts	Output		
ŌĒ	s	I <sub>0</sub>	I <sub>1</sub>	z		
Н	Х	Х	Х	Z		
L	Н	Х	L	L		
L	Н	Х	Н	Н		
L	L	L	Χ	L		
L	L	Н	X	Н		

H = HIGH Voltage Level L = LOW Voltage Level

- X = Immaterial Z = High Impedance

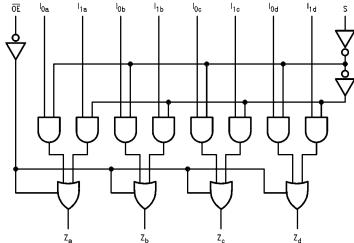
#### **Functional Description**

The 74F257A is a quad 2-input multiplexer with 3-STATE outputs. It selects four bits of data from two sources under control of a Common Data Select input. When the Select input is LOW, the  $I_{0x}$  inputs are selected and when Select  $\,$ is HIGH, the  $\ensuremath{I_{1x}}$  inputs are selected. The data on the selected inputs appears at the outputs in true (noninverted) form. The device is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equation for the outputs is shown below:

$$Z_n = \overline{OE} \bullet (I_n \bullet S + I_{on} \bullet \overline{S})$$

When the Output Enable input  $(\overline{OE})$  is HIGH, the outputs are forced to a high impedance OFF state. If the outputs are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure the Output Enable signals to 3-STATE devices whose outputs are tied together are designed so there is no overlap.

# **Logic Diagram**



 $Z_{a} \qquad \qquad Z_{b} \qquad \qquad Z_{c} \qquad \qquad Z_{d}$  Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

# Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{ll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \end{array}$ 

Junction Temperature under Bias -55°C to +150°C

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$ 

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to +5.5V} \end{array}$ 

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA) ESD Last Passing Voltage (Min) 4000V

Free Air Ambient Temperature  $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$  Supply Voltage +4.5V to +5.5V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

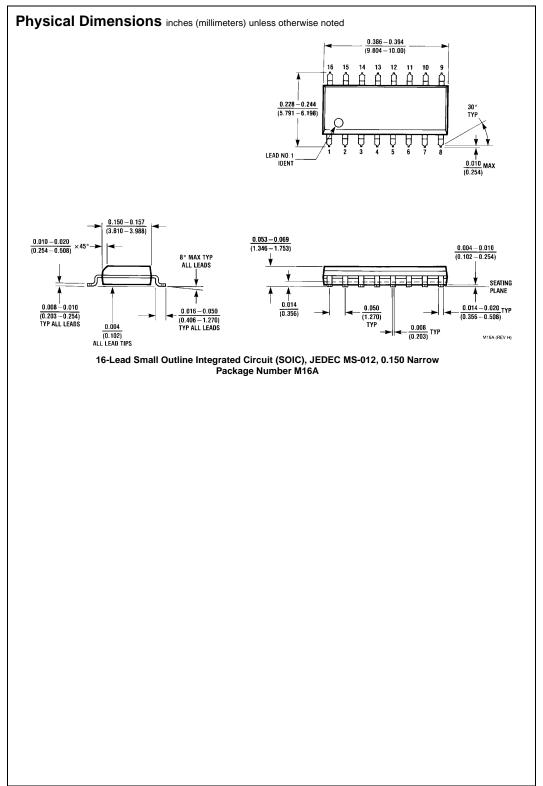
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

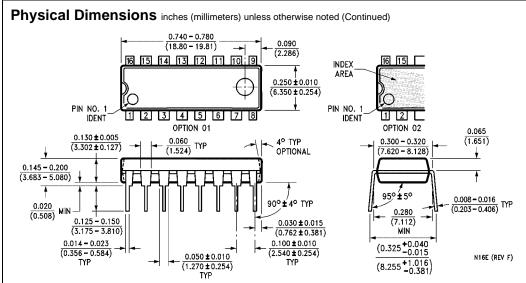
Symbol	Paramete	r	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions	
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Voltag	e			-1.2	V	Min	I <sub>IN</sub> = -18 mA	
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5					I <sub>OH</sub> = -1 mA	
	Voltage	10% V <sub>CC</sub>	2.4			V	Min	$I_{OH} = -3 \text{ mA}$	
		$5\% V_{CC}$	2.7			V	IVIIII	$I_{OH} = -1 \text{ mA}$	
		$5\% V_{CC}$	2.7					$I_{OH} = -3 \text{ mA}$	
V <sub>OL</sub>	Output LOW Voltage	10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 24 mA	
I <sub>IH</sub>	Input HIGH				5.0	μА	Max	V <sub>IN</sub> = 2.7V	
	Current				5.0	μΑ	iviax	v <sub>IN</sub> = 2.7 v	
I <sub>BVI</sub>	Input HIGH Current				7.0	μА	Max	V <sub>IN</sub> = 7.0V	
	Breakdown Test				7.0	μΑ Мах		v <sub>IN</sub> = 7.0v	
I <sub>CEX</sub>	Output HIGH				50		May	V V	
	Leakage Current				50	μА	Max	$V_{OUT} = V_{CC}$	
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu A$	
	Test		4.73			V	0.0	All Other Pins Grounded	
l <sub>OD</sub>	Output Leakage				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV	
	Circuit Current				3.73	μΛ	0.0	All Other Pins Grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	V <sub>IN</sub> = 0.5V	
l <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V	
l <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V	
los	Output Short-Circuit Curre	ent	-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>ZZ</sub>	Bus Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V	
Іссн	Power Supply Current			9.0	15	mA	Max	V <sub>O</sub> = HIGH	
I <sub>CCL</sub>	Power Supply Current			14.5	22	mA	Max	$V_O = LOW$	
I <sub>CCZ</sub>	Power Supply Current			15	23	mA	Max	V <sub>O</sub> = HIGH Z	

# **AC Electrical Characteristics**

	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = 5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = 5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = 5.0V$ $C_L = 50$ pF		Units
Symbol									
		t <sub>PLH</sub>	Propagation Delay	2.5	4.5	5.5	2.0	7.0	2.0
$t_{PHL}$	$I_n$ to $Z_n$	2.0	4.2	5.5	1.5	7.0	2.0	6.0	115
t <sub>PLH</sub>	Propagation Delay	4.0	5.0	9.5	3.5	11.5	3.5	10.5	ns
t <sub>PHL</sub>	S to Z <sub>n</sub>	2.5	6.5	7.0	2.5	9.0	2.5	8.0	115
t <sub>PZH</sub>	Output Enable Time	2.0	5.9	6.0	2.0	8.0	2.0	7.0	
$t_{PZL}$		2.5	5.5	7.0	2.5	9.0	2.5	8.0	ns
t <sub>PHZ</sub>	Output Disable Time	2.0	4.3	6.0	2.0	7.0	2.0	7.0	115
$t_{PLZ}$		2.0	4.5	6.0	2.0	8.5	2.0	7.0	



5



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

www.fairchildsemi.com